

**Notice of References Cited**

Application/Control No.

10/735,989

Applicant(s)/Patent Under  
Reexamination  
MITRA ET AL.

Examiner

Leonid M. Fastovsky

Art Unit

3742

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0062468	04-2004	Lee, Gwo-Bin	385/014
	B	US-5,855,801	01-1999	Lin et al.	216/2
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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